Total	l No.	of Questions : 8] SEAT No. :	
P3656		[Total No. of Pages	: 2
		[4859] - 1053	
		B.E. (Electronics) (Semester - I)	
		Advanced Measurement Systems	
		(2012 Pattern)	
		30 Hours] [Max. Marks : ons to the candidates:	70
Insu	1) 2) 3)	Solve Q.1 or Q.2, Q.3 or Q.4, Q.5 or Q.6, Q.7 or Q.8. Figures to the right indicate full marks. Assume suitable data, if necessary.	
Q1)	a)	Explain in detail signal integrity design issues.	[6]
	b)	Draw the architecture and explain in detail Logic Analyzer. State applications.	its [8]
	c)	Explain embedded communication using CAN.	[6]
		OR	
Q2)	a)	State and explain electrical validation and debug with MSO Ser Oscilloscopes.	ies [8]
	b)	Explain hardware design and testing methods of Spectrum Analyzer.	[6]
	c)	Explain serial bus decode test instruments for USB and PCI Express	s. [6]

- Q3) a) Explain measurement of microwave power bridge circuit using thermistors and barraters.[8]
 - b) Explain single line cavity coupling system for wavelength measurement. [8]

OR

- **Q4)** a) Draw and explain the fundamental set up for advanced radar system. [8]
 - b) What are microwave enclosures and electromagnetic compatibility? Explain EMI and EMC measurements. [8]

Q5)	a)	What is virtual instrumentation? Explain test system development usivirtual instrumentation.	ing [8]
	b)	Explain the application of TDM and PSK in instrumentation.	[8]
		OR	
Q6)	a)	Explain hardware and software role in virtual instrumentation.	[8]
	b)	Explain Lab View based Data acquisition system design.	[8]
Q7)	a)	Explain application of counter for frequency and capacitance meter.	[6]
	b)	What are the types of ADC and DAC? Enlist the specifications of AI and DAC.	DC [6]
	c)	Explain data loggers in detail.	[6]
		OR	
Q8)	Writ	e short note on any three:	18]
	a)	Automation in digital instruments.	
	b)	Analog mixers.	
	c)	V to F converter.	



d)

Universal Counter.